

**12 A four-quadrant triacs, sensitive gate** Rev. 02 — 12 March 2008

**Product data sheet** 

## 1. Product profile

### 1.1 General description

Passivated sensitive gate triac in a SOT78 plastic package.

### 1.2 Features

- Very sensitive gate
- Direct interfacing to logic level ICs
- Gate triggering in four quadrants
- Direct interfacing to low power gate drive circuits

### **1.3 Applications**

 General purpose switching and phase control

### 1.4 Quick reference data

- V<sub>DRM</sub> ≤ 600 V (BT138-600D)
- V<sub>DRM</sub> ≤ 600 V (BT138-600E)
- V<sub>DRM</sub> ≤ 800 V (BT138-800E)
- I<sub>GT</sub>  $\leq$  5 mA (BT138-600D)
- I<sub>GT</sub>  $\leq$  10 mA (BT138-600E)
- $I_{GT} \le 10 \text{ mA} (BT138-800E)$
- I<sub>T(RMS)</sub> ≤ 12 A
- I<sub>TSM</sub>  $\leq$  95 A (t = 20 ms)

230 V lamp dimmers

- $I_{GT} \le 10 \text{ mA} (T2 G +) (BT138-600D)$
- I  $I_{GT} \le 25 \text{ mA} (T2-G+) (BT138-600E)$
- I<sub>GT</sub> ≤ 25 mA (T2– G+) (BT138-800E)



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### 2. Pinning information

Table 1. Pi	inning		
Pin	Description	Simplified outline	Graphic symbol
1	main terminal 1 (T1)		NI
2	main terminal 2 (T2)	mb	T2-T1
3	gate (G)	۲ 🔾 ۲	`G sym051
mb	mounting base; main terminal 2 (T2)		

SOT78 (TO-220AB)

## 3. Ordering information

#### Table 2.Ordering information

Type number	Package				
	Name	Description	Version		
BT138-600D	TO-220AB	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead	d SOT78		
BT138-600E		ТО-220АВ			
BT138-800E					

## 4. Limiting values

#### Table 3.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DRM</sub>	repetitive peak off-state voltage				
		BT138-600D	<u>[1]</u> _	600	V
		BT138-600E	<u>[1]</u> _	600	V
		BT138-800E	-	800	V
I <sub>T(RMS)</sub>	RMS on-state current	full sine wave; T <sub>mb</sub> ≤ 99 °C; see <u>Figure 4</u> and <u>5</u>	-	12	А
I <sub>TSM</sub>	non-repetitive peak on-state current	full sine wave; $T_j = 25 \text{ °C prior to}$ surge; see Figure 2 and 3			
		t = 20 ms	-	95	А
		t = 16.7 ms	-	105	А
l <sup>2</sup> t	I <sup>2</sup> t for fusing	t <sub>p</sub> = 10 ms	-	45	A <sup>2</sup> s

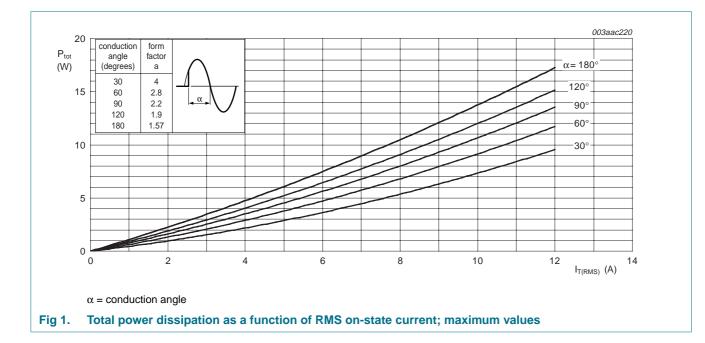
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#### Table 3. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
dl <sub>T</sub> /dt rate of rise of c	rate of rise of on-state current	I <sub>TM</sub> = 20 A; I <sub>G</sub> = 0.2 A; dI <sub>G</sub> /dt = 0.2 A/μs			
		T2+ G+	-	50	A/μs
		T2+ G-	-	50	A/μs
		T2– G–	-	50	A/μs
		T2– G+	-	10	A/μs
I <sub>GM</sub>	peak gate current		-	2	А
P <sub>GM</sub>	peak gate power		-	5	W
P <sub>G(AV)</sub>	average gate power	over any 20 ms period	-	0.5	W
T <sub>stg</sub>	storage temperature		-40	+150	°C
Tj	junction temperature		-	125	°C

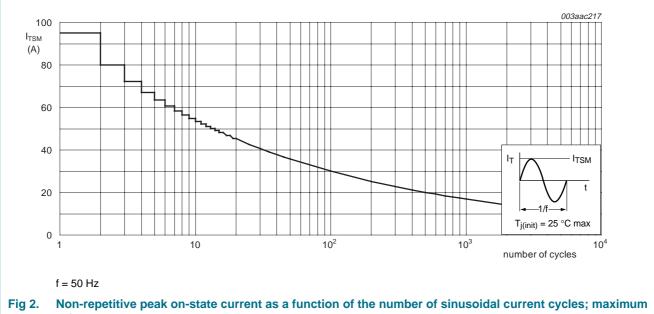
[1] Although not recommended, off-state voltages up to 800 V may be applied without damage, but the triac may switch to the on-state. The rate of rise of current should not exceed 15 A/µs.



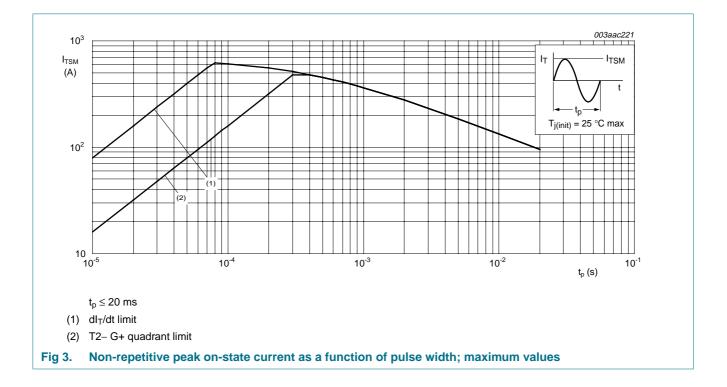
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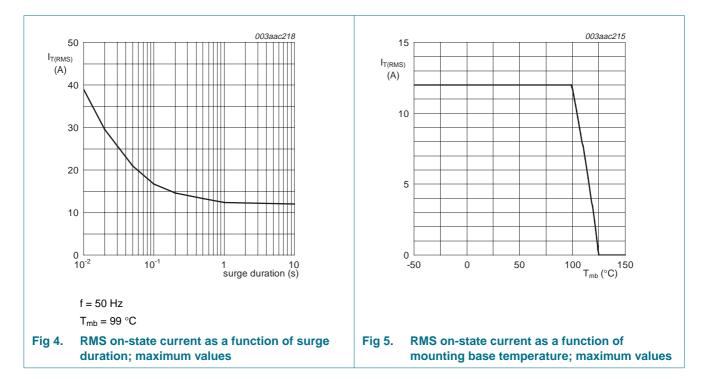
values



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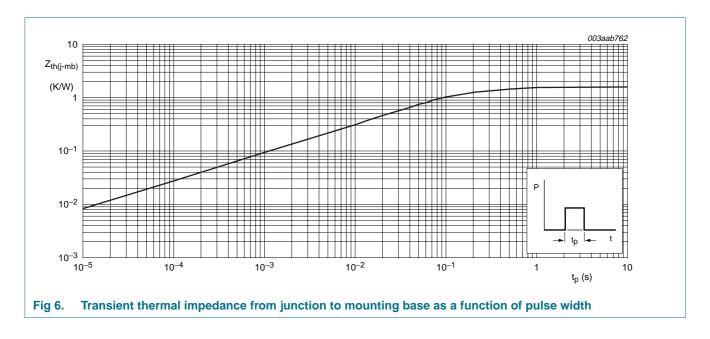
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### 5. Thermal characteristics

#### Table 4. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
$R_{\text{th}(j-mb)}$	thermal resistance from junction to mounting base	full cycle; see Figure 6	-	-	1.5	K/W
R <sub>th(j-a)</sub>	thermal resistance from junction to ambient	full cycle; in free air	-	60	-	K/W



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## 6. Static characteristics

#### Table 5. Static characteristics

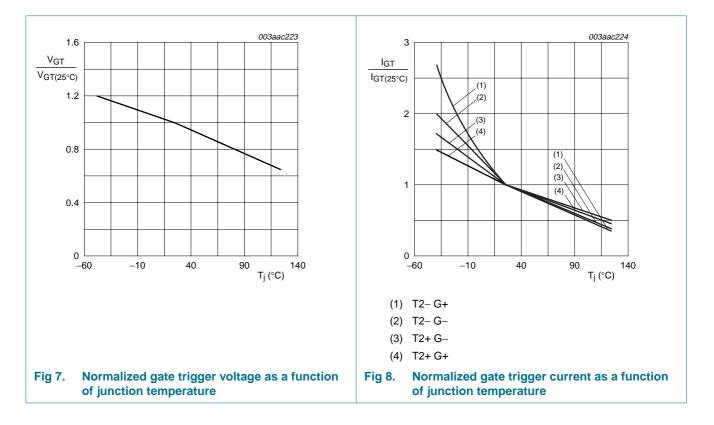
 $T_i = 25 \circ C$  unless otherwise specified.

Symbol	Parameter	Conditions	BT138	-600D		BT138 BT138			Unit
			Min	Тур	Max	Min	Тур	Max	
I <sub>GT</sub>	gate trigger current	$V_D = 12 \text{ V}; \text{ I}_T = 0.1 \text{ A};$ see Figure 8						·	·
		T2+ G+	-	1.3	5	-	2.5	10	mA
		T2+ G–	-	2.8	5	-	4.0	10	mA
		T2– G–	-	3.2	5	-	5.0	10	mA
		T2– G+	-	5.5	10	-	11	25	mA
IL	L latching current	V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; see <u>Figure 10</u>							
		T2+ G+	-	-	15	-	-	30	mA
		T2+ G–	-	-	20	-	-	40	mA
		T2– G–	-	-	15	-	-	30	mA
		T2– G+	-	-	20	-	-	40	mA
I <sub>H</sub>	holding current	V <sub>D</sub> = 12 V; I <sub>G</sub> = 0.1 A; see <u>Figure 11</u>	-	-	10	-	-	30	mA
V <sub>T</sub>	on-state voltage	I <sub>T</sub> = 15 A; see Figure 9	-	1.4	1.65	-	1.4	1.65	V
V <sub>GT</sub>	gate trigger voltage	I <sub>T</sub> = 0.1 A; see Figure 7							
		V <sub>D</sub> = 12 V;	-	0.7	1.5	-	0.7	1.5	V
		$V_D = V_{DRM}; T_j = 125 \ ^{\circ}C$	0.25	0.4	-	0.25	0.4	-	V
I <sub>D</sub>	off-state current	V <sub>D</sub> = V <sub>DRM(max)</sub> ; T <sub>j</sub> = 125 °C	-	0.1	0.5	-	0.1	0.5	mA

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## 7. Dynamic characteristics

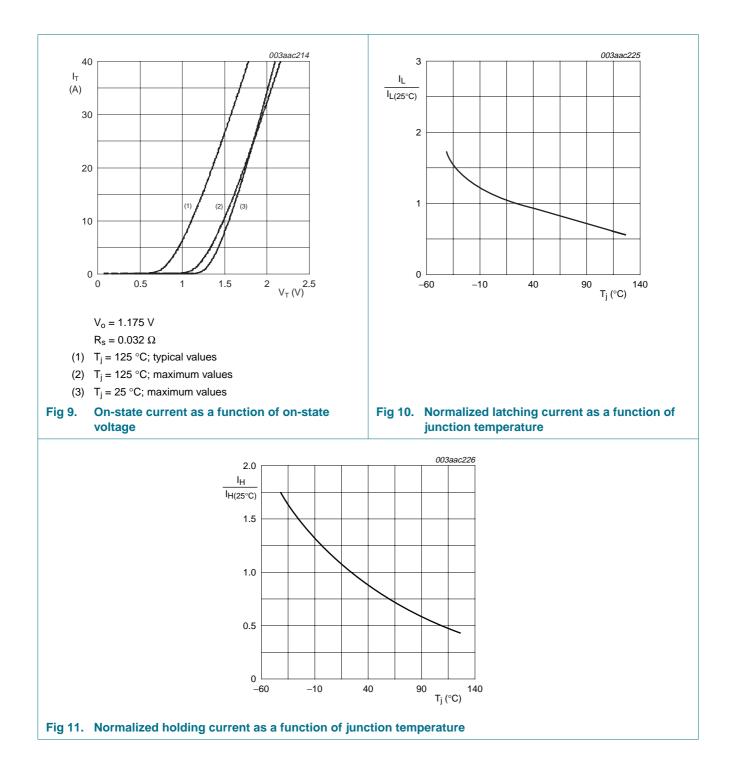
Table 6.	Dynamic characteristics								
Symbol	Parameter	Conditions	BT13	8-600D		-	8-600E 8-800E		Unit
			Min	Тур	Max	Min	Тур	Max	
dV <sub>D</sub> /dt	rate of rise of off-state voltage	$\begin{split} V_{DM} &= 0.67 \times V_{DRM(max)}; \\ exponential waveform; \\ gate open circuit; \\ T_j &= 110 \ ^\circ C \end{split}$	-	50	-	-	150	-	V/µs
t <sub>gt</sub>	gate-controlled turn-on time	$    I_{TM} = 16 \text{ A}; \\ V_D = V_{DRM(max)}; \\ I_G = 0.1 \text{ A}; \text{ d}I_G/\text{d}t = 5 \text{ A}/\mu\text{s} $	-	2	-	-	2	-	μs



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## 8. Package outline

							Ш	q q L2			unting ase		-220A			
DIMENS	IONS (n	nm are t	he origi	nal dime	nsions)		0 LL		5  ale	0 mm بـــا						
UNIT	A	A1	b	b <sub>1</sub>	c	D	D <sub>1</sub>	E	e	L	L <sub>1</sub>	L <sub>2</sub> max.	р	q	Q	
mm	4.7 4.1	1.40 1.25	0.9 0.6	1.45 1.00	0.7 0.4	16.0 15.2	6.6 5.9	10.3 9.7	2.54	15.0 12.8	3.30 2.79	3.0	3.8 3.5	3.0 2.7	2.6 2.2	
							EFERE									ISSUE DATE
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#### Fig 12. Package outline SOT78 (TO-220AB)

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## 9. Revision history

Table 7. Revision histo	ory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BT138_SER_D_E_2	20080312	Product data sheet	-	BT138_SERIES_E_1
Modifications:	guidelines of • Legal texts h	f this data sheet has been red NXP Semiconductors. ave been adapted to the new o product added	<b>.</b>	
BT138_SERIES_E_1	19970901	Product data sheet	-	-

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Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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